4-Channel LCD EMI Filter Array plus 4-Channel ESD Protection Array

Features

- Functionally and pin compatible with CMD's CSPEMI607
- Four channels of combined EMI/RFI filtering plus ESD protection
- Four additional channels of ESD-only protection
- Better than 30dB attenuation (typical) at 1 GHz
- ±15kV ESD protection on all channels (IEC 61000-4-2 Level 4, contact discharge)
- ±30kV ESD protection on all channels (HBM)
- Chip Scale Package features extremely low lead inductance for optimum filter and ESD performance
- 15-bump, 2.960mm X 1.330mm footprint Chip Scale Package (CSP)
- Optiguard[™] coated for improved reliability
- Lead-free version available

Applications

- LCD data lines in mobile handsets
- EMI filtering and ESD protection for both data and I/O ports
- Mobile Handsets
- Handheld PCs / PDAs
- Notebook Computers

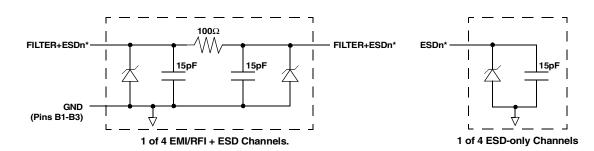
Product Description

The CM1421 is a multichannel array consisting of four low-pass filters with integrated ESD protection and four ESD-only protection channels designed to reduce EMI/ RFI emissions on LCD data lines in mobile handsets. The CM1421 has component values of $15pF-100\Omega$ -15pF. These devices include ESD protection diodes on every pin, which provide a very high level of protection for sensitive electronic components that may be subjected to electrostatic discharge (ESD). The ESD diodes connected to the filter ports are designed and characterized to safely dissipate ESD strikes of ±15kV, beyond the maximum requirement of the IEC 61000-4-2 international standard. Using the MIL-STD-883 (Method 3015) specification for Human Body Model (HBM) ESD, the pins are protected for contact discharges at greater than ±30kV.

This device is particularly well suited for portable electronics (e.g. wireless handsets, PDAs, notebook computers) because of its small package format and easyto-use pin assignments. In particular, the CM1421 is ideal for EMI filtering and protecting data lines from ESD for the LCD display in clamshell handsets.

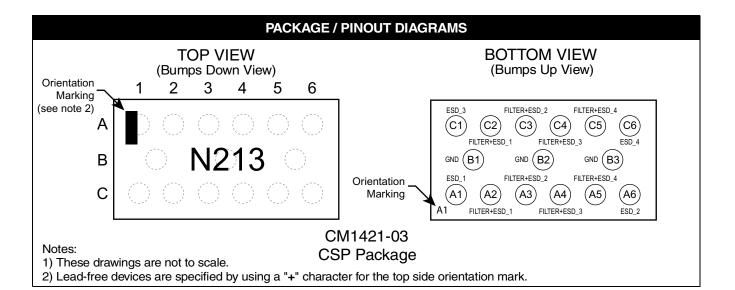
The CM1421 incorporates Optiguard[™] coating which results in improved reliability. The CM1421 is available in space-saving, low-profile chip-scale packages with optional lead-free finishing.

Electrical Schematic



* See Package/Pinout Diagram for expanded pin information

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		PIN DESCRIPTIONS
PIN(s)	NAME	DESCRIPTION
A1	ESD_1	ESD Channel 1
A2	FILTER+ESD_1	Filter + ESD Channel 1
A3	FILTER+ESD_2	Filter + ESD Channel 2
A4	FILTER+ESD_3	Filter + ESD Channel 3
A5	FILTER+ESD_4	Filter + ESD Channel 4
A6	ESD_2	ESD Channel 2
B1-B3	GND	Device Ground
C1	ESD_3	ESD Channel 3
C2	FILTER+ESD_1	Filter + ESD Channel 1
C3	FILTER+ESD_2	Filter + ESD Channel 2
C4	FILTER+ESD_3	Filter + ESD Channel 3
C5	FILTER+ESD_4	Filter + ESD Channel 4
C6	ESD_4	ESD Channel 4

Ordering Information

PART NUMBERING INFORMATION							
		Standar	rd Finish	Lead-free Finish			
		Ordering Part		Ordering Part			
Pins	Package	Number ¹	Part Marking	Number ¹	Part Marking ²		
15	CSP	CM1421-03CS	N213	CM1421-03CP	N213		

Note 1: Parts are shipped in Tape & Reel form unless otherwise specified.

Note 2: Lead-free devices are specified by using a "+" character for the top side orientation mark.

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Specifications

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	RATING	UNITS			
Storage Temperature Range	-65 to +150	°C			
DC Power per Resistor	100	mW			
DC Package Power Rating	500	mW			

STANDARD OPERATING CONDITIONS						
PARAMETER	RATING	UNITS				
Operating Temperature Range	-40 to +85	°C				

	ELECTRICAL OPERATING CHARACTERISTICS (SEE NOTE1)						
SYMBOL	PARAMETER	CONDITIONS	MIN	ТҮР	MAX	UNITS	
R	Resistance		80	100	120	Ω	
С	Capacitance	At 2.5V DC	12	15	18	pF	
V _{DIODE}	Diode Standoff Voltage	I _{DIODE} =10μA	5.5			V	
I _{LEAK}	Diode Leakage Current (reverse bias)	V _{DIODE} =3.3V		100		nA	
V _{SIG}	Signal Voltage Positive Clamp Negative Clamp	I _{LOAD} = 10mA	5.6 -1.5	6.8 -0.8	9.0 -0.4	V V	
V _{ESD}	In-system ESD Withstand Voltage a) Human Body Model, MIL-STD-883, Method 3015 b) Contact Discharge per IEC 61000-4-2 Level 4	Notes 2,4 and 5	±30 ±15			kV kV	
V _{CL}	Clamping Voltage during ESD Discharge MIL-STD-883 (Method 3015), 8kV Positive Transients Negative Transients	Notes 2,3,4 and 5		+12 -7		V V	
f _c	Cut-off Frequency Z _{SOURCE} =50Ω, Z _{LOAD} =50Ω	R=100Ω, C=15pF		120		MHz	

Note 1: $T_A=25^{\circ}C$ unless otherwise specified.

Note 2: ESD applied to input and output pins with respect to GND, one at a time.

Note 3: Clamping voltage is measured at the opposite side of the EMI filter to the ESD pin. For example, if ESD is applied to Pin A2, then clamping voltage is measured at Pin C2.

Note 4: Unused pins are left open

Note 5: These parameters are guaranteed by design and characterization.

Performance Information

Typical Filter Performance (T_A=25°C, DC Bias=0V, 50 Ohm Environment)

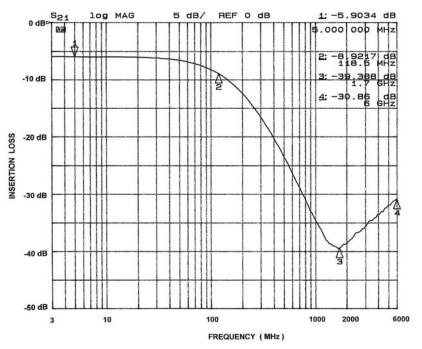
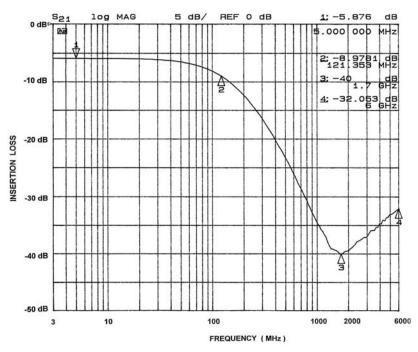


Figure 1. Insertion Loss VS. Frequency (A1-C1 to GND B1)





Performance Information (cont'd)

Typical Filter Performance (T_A=25°C, DC Bias=0V, 50 Ohm Environment)

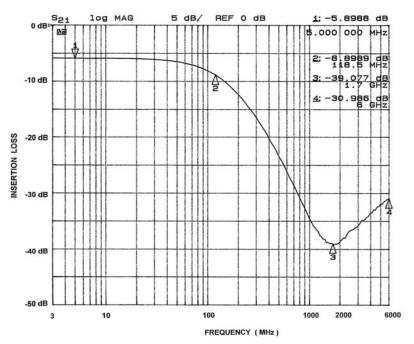


Figure 3. Insertion Loss VS. Frequency (A3-C3 to GND B2)

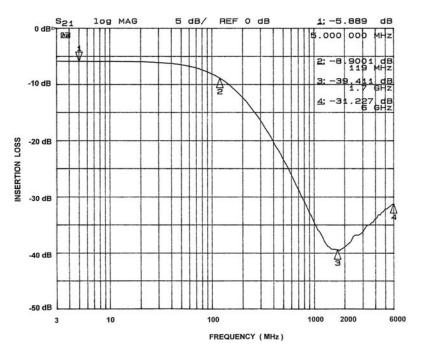


Figure 4. Insertion Loss VS. Frequency (A4-C4 to GND B2)

Performance Information (cont'd)

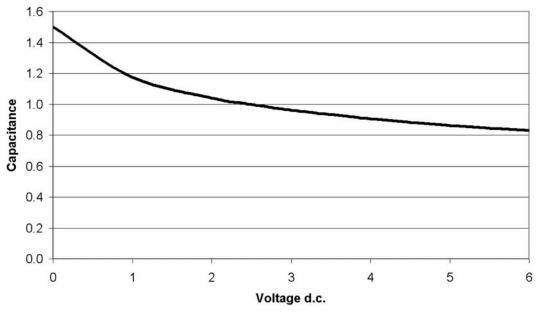
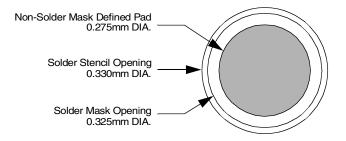


Figure 5. Filter Capacitance vs. Input Voltage over Temperature (normalized to capacitance at 2.5VDC and 25°C)

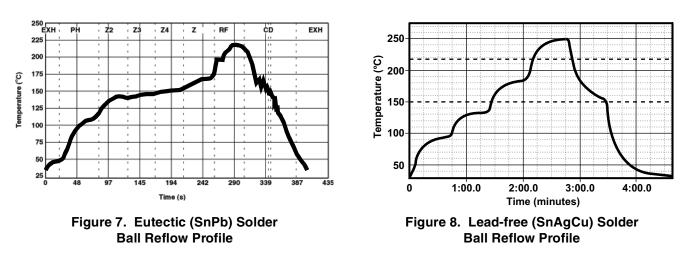
Application Information

Refer to Application Note AP-217, "The Chip Scale Package", for a detailed description of Chip Scale Packages offered by California Micro Devices.

PRINTED CIRCUIT BOARD RECOMMENDATIONS						
PARAMETER VALUE						
Pad Size on PCB	0.275mm					
Pad Shape	Round					
Pad Definition	Non-Solder Mask defined pads					
Solder Mask Opening	0.325mm Round					
Solder Stencil Thickness	0.125mm - 0.150mm					
Solder Stencil Aperture Opening (laser cut, 5% tapered walls)	0.330mm Round					
Solder Flux Ratio	50/50 by volume					
Solder Paste Type	No Clean					
Pad Protective Finish	OSP (Entek Cu Plus 106A)					
Tolerance — Edge To Corner Ball	±50μm					
Solder Ball Side Coplanarity	±20μm					
Maximum Dwell Time Above Liquidous	60 seconds					
Soldering Maximum Temperature	260°C					







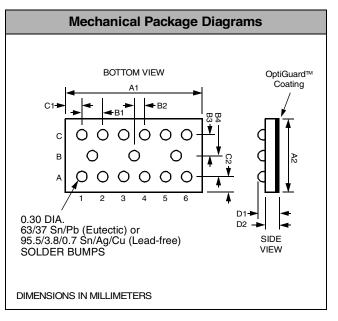
Mechanical Details

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CSP Mechanical Specifications

CM1421 devices are packaged in a custom Chip Scale Package (CSP). Dimensions are presented below. For complete information on CSP packaging, see the California Micro Devices CSP Package Information document.

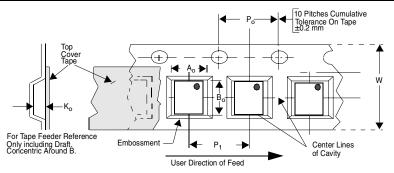
PACKAGE DIMENSIONS								
Pack	age	Custom CSP						
Bum	nps	15						
Dim	Millimeter		rs					
Dim	Min	Nom	Max	Min	Nom	Мах		
A1	2.915	2.960	3.005	0.1148	0.1165	0.1183		
A2	1.285	1.330 1.375 0.0506 0.0524				0.0541		
B1	0.495	0.500	0.500 0.505 0.0195		0.0197	0.0199		
B2	0.245	0.250	0.255	0.0096	0.0098 0.0171	0.0100 0.0173		
B3	0.430	0.435	0.440	0.0169				
B4	0.430	0.435	0.435 0.440 0.0169 0.230 0.280 0.0071		0.0171	0.0173		
C1	0.180	0.230			0.0091	0.0110		
C2	0.180	0.230	0.280	0.0071	0.0091	0.0110		
D1	0.600	0.670	0.739	0.0236	0.0264	0.0291		
D2	0.394	0.445	0.495	0.0155	0.0175	0.0195		
# per taj ree		3500 pieces						
	Controlling dimension: millimeters							



Package Dimensions for CM1421 Chip Scale Package

CSP Tape and Reel Specifications

PART NUMBER	CHIP SIZE (mm)	POCKET SIZE (mm) B ₀ X A ₀ X K ₀	TAPE WIDTH W	REEL DIAMETER	QTY PER REEL	P ₀	P 1
CM1421	2.96 X 1.33 X 0.6	3.10 X 1.45 X 0.74	8mm	178mm (7")	3500	4mm	4mm





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